

<b>Notice of References Cited</b>	Application/Control No. 10/572,818		Applicant(s)/Patent Under Reexamination BICHOT ET AL.	
	Examiner ZEWDU BEYEN		Art Unit 2419	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2008/0317029	12-2008	TASAKI et al.	370/390
*	B	US-2007/0028002	02-2007	McCanne, Steven	709/238
*	C	US-2004/0013583	01-2004	Burkhardt, Robert W.	422/186.3
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	M	US-			

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#### NON-PATENT DOCUMENTS

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